

Impact of pump wavelength on terahertz emission of a cavity-enhanced spintronic trilayer

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ABSTRACT

We systematically study the pump-wavelength dependence of terahertz pulse generation in thin-film spintronic THz emitters composed of a ferromagnetic CoFeB layer between adjacent nonmagnetic W and Pt layers. We find that the efficiency of THz generation is essentially flat for excitation by 150 fs pulses with center wavelengths ranging from 900 to 1500 nm, demonstrating that the spin current does not depend strongly on the pump photon energy. We show that the inclusion of dielectric overlayers of TiO₂ and SiO₂, designed for a particular excitation wavelength, can enhance the terahertz emission by a factor of up to two in field.

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Terahertz (THz) radiation is non-ionizing and, therefore, safe for many applications, ranging from micro- and macroscopic imaging and spectroscopy to wireless communication.^{1–4} However, the spectroscopically interesting THz frequency band near 1 THz is not easily accessible. Electronic sources such as oscillators can only provide high (milliwatt) output levels up to a few 100 GHz,⁵ while optical sources such as quantum cascade lasers are typically limited to frequencies >2 THz at room temperature.^{4,6} To fill this “gap,” considerable effort has been garnered towards sources capable of frequency mixing and optical rectification,⁷ typically driven by femtosecond lasers.

To date, most THz emitting materials have been found to be insulators or semiconductors.⁸ Recently, THz emitters based on magnetic, metallic thin films have been demonstrated which emit THz radiation under illumination by femtosecond pulses.^{9–15} We here focus on trilayer thin-film emitters formed from a ferromagnetic (FM) layer between two non-ferromagnetic (NM) layers. A two-step process is thought to generate THz radiation:¹⁶ Upon excitation by the femtosecond pump pulse, an ultrashort out-of-plane spin current polarized along the FM magnetization is injected from the FM into the NM

layers. Thereafter, the inverse spin Hall effect converts the laser-induced spin current into a transverse in-plane charge current within the NM layer which leads to the emission of a THz pulse into the optical far-field.^{16–18}

One of the most efficient films of this type⁹ comprises W, CoFeB, and Pt layers. Importantly, Pt and W feature a spin Hall angle of opposite sign, resulting in a constructive superposition of the two charge currents in these layers. The result is an ultra-broadband THz emitter, capable of delivering pulses spanning 0.1 to 30 THz.⁹ With an active region only a few nanometers thick in total, these emitters can generate as much THz amplitude as a phase-matched electro-optic crystal of millimeter thickness.⁹ Such highly efficient, but thin, THz emitters show much promise, particularly for near-field measurement or applications that benefit from the absence of phase matching.

Most studies of these THz emitters have been carried out using Ti:sapphire laser sources with wavelengths around 800 nm. However, many thin metal films show a rather wavelength-independent absorptance in the visible and near infrared, such that the THz-generation efficiency may naively be expected to be

largely independent of the pump wavelength.⁹ Such wavelength-independent emission would be a great advantage of these types of emitters, allowing users free choice in excitation laser sources. Such a feature is particularly interesting in terms of fiber-based lasers that operate at infrared wavelengths above 1 μm .

In this paper, we investigate the pump-wavelength dependence of THz emission of W|CoFeB|Pt trilayer emitters using a continuously tunable femtosecond laser source. We find that the efficiency of THz generation is surprisingly flat for excitation by 150 fs pulses with central wavelengths ranging from 900 to 1500 nm. This observation reveals that the photon energy has little effect on the number of electrons contributing to transport of spin polarization and that the key parameter is the total amount of energy deposited by the pump pulse. We demonstrate that the inclusion of dielectric overlayers (TiO_2 and SiO_2), forming a cavity with the substrate, can enhance emission by up to a factor of four in intensity in the frequency window from 0 to 2 THz. This optimized emitter can be readily used in setups driven by fiber-based systems with wavelengths around 1030 nm.

A schematic of the samples is shown in Fig. 1. The emitters have each 10 mm by 7 mm in area, with layers of W, CoFeB, and Pt deposited on a sapphire substrate by Ar sputtering using a Singulus Rotaris® deposition system.⁹ The layers of W, CoFeB, and Pt have nominal thicknesses of 2 nm, 1.8 nm, and 2 nm, respectively, giving a total thickness of 5.8 nm for the metallic layers. On six samples, an optical cavity made from alternating dielectric overlayers of TiO_2 (thickness 113 nm and near-infrared index of refraction 2.265)¹⁹ and SiO_2 (185 nm, 1.455), with a total overlayer thickness of 1.495 μm , was deposited by plasma-assisted electron beam evaporation using a Leybold 1104 coating platform. Note that the overlayer thicknesses were optimized

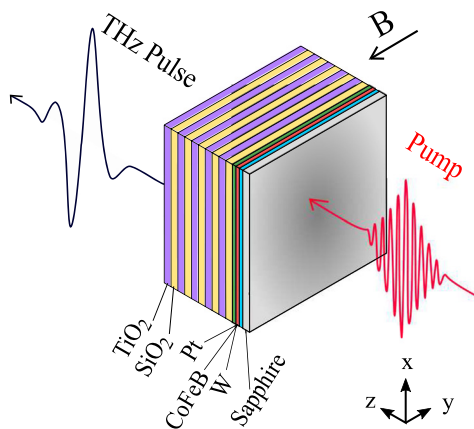


FIG. 1. Schematic of a spintronic trilayer with added dielectric cavity, grown on 0.5 mm of sapphire (Al_2O_3). The near-infrared pump pulse, incident through the substrate, is partially absorbed in the metallic layers, launching a spin current from the ferromagnetic (FM) layer into the nonmagnetic (NM) layers. The inverse spin Hall effect converts this ultrashort out-of-plane spin current into an in-plane charge current resulting in the emission of THz radiation into the optical far-field. A weak in-plane magnetic field (B) determines the magnetization direction and the linear polarization of the emitted THz field.

numerically to give a flat response at the target wavelength. The near-infrared transmission spectrum, normalized by the optical transmission of the sapphire substrate, was recorded for each sample using a monochromator (Oriel) and a Quartz Tungsten-Halogen lamp (Thorlabs) [see Figs. 2(a) and 2(b)].

THz emission was investigated using wavelength-tunable near-infrared pump pulses (duration ~ 150 fs, spot diameter ~ 4 mm, and fluence $\sim 0.1 \text{ J m}^{-2}$) incident normal to the sample surface. They were generated by an optical parametric amplifier (Light Conversion TOPAS) driven by an 800 nm Ti:Sapphire amplified laser (~ 100 fs, repetition rate of 1 kHz). When varying the pump wavelength, we paid particular attention to keeping the other pump-pulse parameters, in particular, energy, duration, and focus diameter, constant; we worked far from the focal point of our lens to maintain the spot diameter. The resulting THz pulse, emitted in the forward direction, is detected through electro-optic sampling with 800 nm pulses from our amplified laser system using a 1 mm thick, (110)-oriented ZnTe crystal. For all samples, a neodymium magnet attached to the emitter holder approximately 7 mm from the edge of the film gives an in-plane magnetic field of ~ 13 mT, as depicted in Fig. 1. This determines the linear polarization of the emitted THz electric field which is always oriented perpendicularly to the magnetic field.

Figure 2(c) shows a typical electro-optic signal waveform of a THz pulse emitted from the bare spintronic trilayer after excitation by a pump pulse with a center wavelength of 1040 nm. The signal amplitude grows approximately linearly for incident pump fluences at least up to 0.4 J m^{-2} (see supplementary material Fig. S1).

In Fig. 2(e), we plot the integrated THz field emitted by a W|CoFeB|Pt trilayer sample for various pump wavelengths in the range from 900 to 1500 nm. Remarkably, over this range, the efficiency of THz generation is wavelength-independent. Importantly, since they originate from the same source, the focus diameter, energy, and duration of the pump pulses are fairly independent of the wavelength in the range of 1000 to 1300 nm. For example, the pulse duration varies by less than 12 fs across this entire range (see supplementary material Figs. S2 and supplementary material Sec. B). An unchanged THz signal amplitude has also been reported¹² for 1550 nm and the significantly shorter wavelength of 800 nm. Our results and those of Ref. 12 indicate that the spin current arises from the hot electrons induced by the pump pulse. The details of the involved optical transitions are insignificant. Therefore, the key parameter is the amount of energy that is deposited by the pump pulse in the electronic system.

Since the THz emission from the spintronic emitters is largely independent of the pump wavelength, one can in principle enhance the emission for any particular wavelength by designing a suitable adjacent cavity (Fig. 1). A straightforward implementation is dielectric overlayers similar to a Bragg mirror, forming a broadband dielectric cavity with the substrate. By placing the lower index material, in this case SiO_2 , next to the trilayer, an intensity maximum is formed within the active THz generation layers. Doing so, for a particular target pump

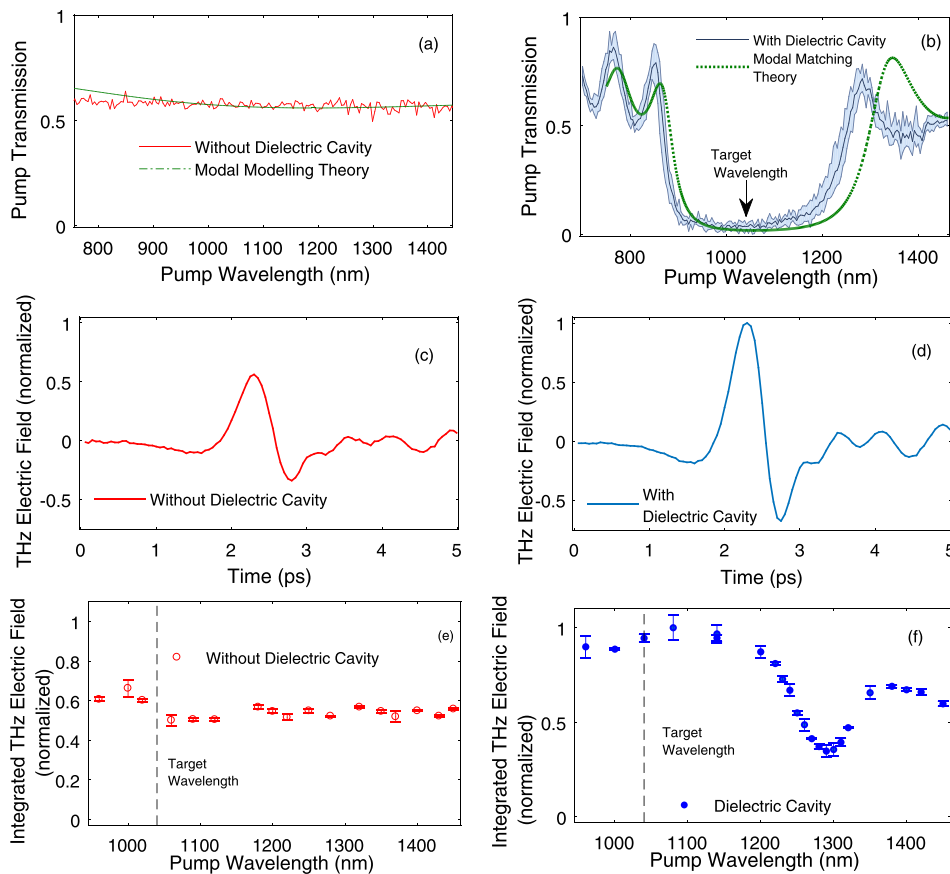


FIG. 2. (a) and (b) Measured transmittance of samples without (left) and with (right) TiO_2 and SiO_2 dielectric overlayers. The blue-shaded region in panel (b) represents variation among the six cavity films due to variation in the fabrication process. Whilst the transmittance of the trilayer alone is relatively flat with the incident wavelength, the trilayer with the dielectric overlayers exhibits a band-stop region between 900 and 1200 nm. Green lines are calculated using modal matching (see [supplementary material](#)). (c) and (d) Typical THz waveforms from the bare trilayer sample (left) and the trilayer with overlayers (right) pumped by $1040 \mu\text{m}$ pulses. (e) and (f) The THz electric field, integrated over the spectrum, emitted without (left) and with (right) dielectric overlayers as a function of the pump wavelength while the energy, focus diameter, and duration of the pump pulses were kept constant. Error bars represent variation in emission between nominally identical samples. Note that the highest value of the THz field has been normalized to one to ease comparison.

wavelength, pump absorption in the metallic trilayer will be maximized and so will the emitted THz radiation. For convenience, we choose a target pump wavelength of 1040 nm aimed at common fiber lasers, specified by the thickness and type of the dielectric layers. To achieve a stop-band with less than 5% transmission, a total of 10 dielectric layers are required. For these coated samples, the total thickness (neglecting the substrate) is $1.495 \mu\text{m}$, corresponding to an optical thickness for THz wavelengths of approximately $9 \mu\text{m}$, which is still very sub-wavelength for THz radiation.

To model the behavior of the emitter with a dielectric cavity, a standard modal matching approach²⁰ is used which can also treat a source within the active region (see [supplementary material](#) Sec. D). In [Fig. 2\(b\)](#), we plot the calculated near-infrared transmission spectrum for the samples with dielectric overlayers (green dotted-dashed line). We expect a transmittance minimum [[Fig. 2\(b\)](#)] and an absorptance maximum (see [supplementary material](#) Sec. D) at the target wavelength of 1040 nm, with a bandwidth of around 300 nm.

In [Fig. 2\(b\)](#), the blue-shaded region represents the distribution of transmittance spectra measured for the six samples with overlayers. While the transmittance [[Fig. 2\(b\)](#)] and absorptance ([supplementary material](#) Fig. S4) of the sample without the dielectric overlayers are fairly flat over the measured range, all

samples with dielectric overlayers show clear band-stop behavior. The minimum transmittance in the measurement, $\sim 3\%$, is consistent with our modeling. The slight shift in the wavelength of the band-stop region between the modeling and experiment likely arises from variation in the refractive indices and/or thicknesses of the dielectric layers. For example, the optical thickness needs to change by only 3.8% with respect to specified values to account for this discrepancy. The band-stop in the region of the target wavelength designates a region where we expect to see enhancement of THz emission.

In [Fig. 2\(f\)](#), we can observe the enhancement in THz emission generated by the dielectric overlayers. For an identical pump fluence, in the band-stop window (900 to 1200 nm), we find a THz field that is a factor of ~ 2 (intensity of a factor ~ 4) larger compared to the trilayer without overlayers. This is slightly larger than the 70% enhancement in field recently reported for a cavity formed from two sets of spintronic layers separated by dielectric spacers.¹³ We also observe reduction in THz emission near the near-infrared transmittance maxima at 1300 nm. In these bandpass regions, the dielectric overlayers act to reduce the near-infrared intensity in the active magnetic layer. For the band-stop region, the factor of two enhancement in THz field emission is observed for the entire fluence range investigated here ([supplementary material](#) Fig. S1).

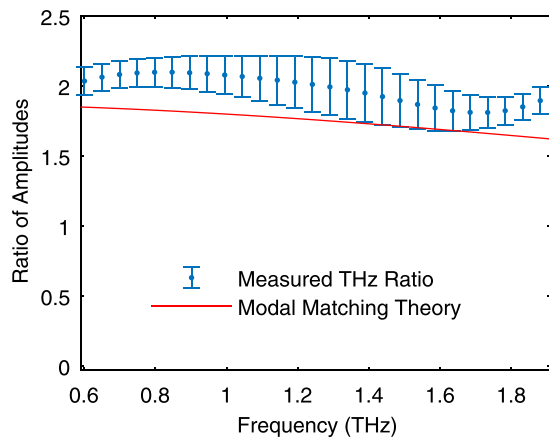


FIG. 3. Measured THz emission enhancement for different THz spectral components, plotting the THz field amplitude emitted from a spintronic trilayer with the dielectric cavity divided by field emitted without cavity, when excited by a pump pulse of 1040 nm. The solid line is a calculation from modal matching theory.

In Fig. 3, we plot the spectral dependence of this observed THz emission enhancement for excitation by a 1040 nm pump pulse (blue dots). The highest enhancement is observed for the lowest THz frequencies. Above 1 THz, we begin to see a slight drop in the field enhancement factor. The most significant limitation within the experiment is the bandwidth of the ZnTe detector, which limits our detection frequencies to <2 THz. However, after normalising the emission, thus removing the effects of the detector response function, absorption manifests itself as a reduction in the field enhancement factor for frequencies >1 THz. Also shown is the prediction from modeling (red line): this is calculated from the modal modeling method using the THz field emitted with and without the dielectric cavity, multiplied by the predicted pump intensity in the active magnetic layer. Our modeling predicts a similar behavior, but with an enhancement factor which decreases more quickly with frequency, an effect which arises due to the frequency dependent absorption of TiO_2 . In our model, we also observe high sensitivity to the precise index of the Pt layer, a material which shows high variation dependent on the morphology.²¹ It is important to note that alternative dielectrics to TiO_2 may well exhibit lower absorption losses and could increase the operational bandwidth of cavity enhanced emitters.

To conclude, we systematically study the pump-wavelength dependence of THz emission of spintronic W/CoFeB/Pt trilayers. We find that the efficiency of THz generation is essentially flat for excitation by 150 fs pulses with central wavelengths ranging from 900 to 1500 nm, indicating that the spin current is largely independent of the pump-photon energy. We demonstrate that the inclusion of dielectric overlayers of TiO_2 and SiO_2 , designed for a particular excitation wavelength, can enhance emission by up to a factor of two in field amplitude in this technologically important range of pump wavelengths. The four-fold enhancement in emitted THz intensity could be further improved using cavities with higher quality factors, matched to the bandwidth of the pump pulse. As shown for pump wavelengths at around

800 nm, shorter pump pulses in the infrared are expected to deliver more broadband THz transients, reaching frequencies of up to 30 THz for pump durations approaching 10 fs.

See [supplementary material](#) for a power dependence of the spintronic trilayer with and without the dielectric cavity, the dependence of the pump-pulse duration on the wavelength, the detector response function of our THz electro-optic detection system, and details on the modal matching theory used for the modeling.^{22–28}

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